

Preliminary Specification: Subject to Change without Notice

N-Channel 150 V MOSFET

Product summary

V_{DS} (V)	$R_{DS(on),max}$ (m Ω)	I_D (A)
150	11 @ $V_{GS} = 10V$	76 ⁽¹⁾

Features

- Low $R_{DS(on)}$ SGT technology
- Low thermal impedance
- Fast switching speed
- 100% avalanche tested

Applications

- DC/DC conversion
- Power switch
- Motor drives

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Package and ordering information

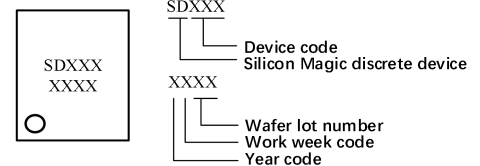
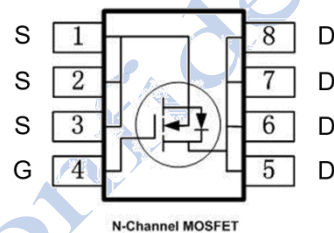
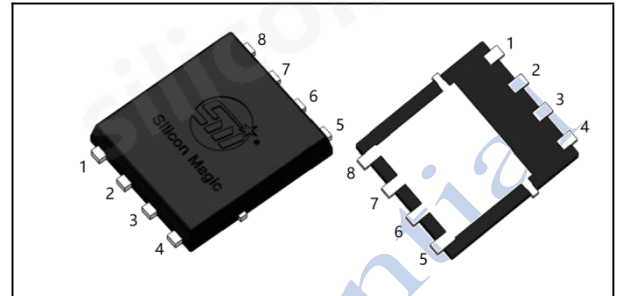
Ordering code	Package	Device code
SDH15N9P3C-AB	PDFN5*6-8L	AMC

1. Maximum ratings

Absolute maximum ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-source voltage		V_{DS}	150	V
Gate-source voltage		V_{GS}	± 20	
Continuous drain current	$T_C = 25^\circ\text{C}$ ⁽¹⁾	I_D	76	A
	$T_C = 100^\circ\text{C}$		48	
	$T_A = 25^\circ\text{C}$ ⁽⁴⁾		10.3	
Pulsed drain current ⁽²⁾		$I_{D,pulse}$	307.2	
Avalanche energy, single pulse ⁽³⁾		E_{AS}	100	mJ
Power dissipation	$T_C = 25^\circ\text{C}$	P_D	138.8	W
	$T_A = 25^\circ\text{C}$ ⁽⁴⁾		2.5	
Operating junction and storage temperature range		T_J, T_{stg}	-55 to 150	$^\circ\text{C}$

PDFN5*6-8L



2. Thermal resistance ratings

Thermal resistance ratings				
Parameter		Symbol	Max.	Unit
Thermal resistance, junction-to-case	Steady state	$R_{\theta JC}$	0.9	°C/W
Thermal resistance, junction-to-ambient ⁽⁴⁾	Steady state	$R_{\theta JA}$	50	

3. Electrical Characteristics

Electrical characteristics (T _J = 25°C unless otherwise noted)						
Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Static parameter						
Drain to source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA	150			V
Gate-source threshold voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	2.8	3.6	4.4	V
Gate-body leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V			±100	nA
Zero gate voltage drain current	I _{DSS}	V _{DS} = 150 V, V _{GS} = 0 V			1	μA
Drain-source on-resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 20 A		9.2	11	mΩ
Forward transconductance ⁽⁵⁾	g _{fs}	V _{DS} = 5 V, I _D = 20 A		43		S
Gate resistance	R _g	f = 1 MHz		2.3		Ω
Dynamic ⁽⁵⁾						
Total gate charge	Q _g	V _{DS} = 75 V, I _D = 20 A, V _{GS} = 10 V		20		nC
Gate-source charge	Q _{gs}			8.2		
Gate-drain charge	Q _{gd}			7.0		
Turn-on delay time	t _{d(on)}	V _{DS} = 75 V, I _D = 20 A, V _{GS} = 10 V, R _{GEN} = 1.6 Ω		10.8		ns
Rise time	t _r			14.5		
Turn-off delay time	t _{d(off)}			3.1		
Fall time	t _f			5.2		
Input capacitance	C _{iss}	V _{DS} = 75 V, V _{GS} = 0 V, f = 1 MHz		1367		pF
Output capacitance	C _{oss}			462		
Reverse transfer capacitance	C _{rss}			20		
Reverse Diode Characteristics ⁽⁵⁾						
Diode forward voltage	V _{SD}	V _{GS} = 0 V, I _F = 20 A		0.9	1.1	V
Reverse recovery time	t _{rr}	V _{DS} = 75 V, I _F = 20 A, di/dt = 100 A/μs		66		ns
Reverse recovery charge	Q _{rr}			100		nC

Notes

- (1) limited by maximum junction temperature.
- (2) Pulse width limited by maximum junction temperature.
- (3) $V_{DS} = 75\text{ V}, V_{GS} = 10\text{ V}, L = 1\text{ mH}$.
- (4) $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5x1.5 in. board of FR-4 material.
- (5) Guaranteed by design, not subject to production testing.

4. Electrical characteristics diagrams

Fig.1 Typ. transfer characteristics

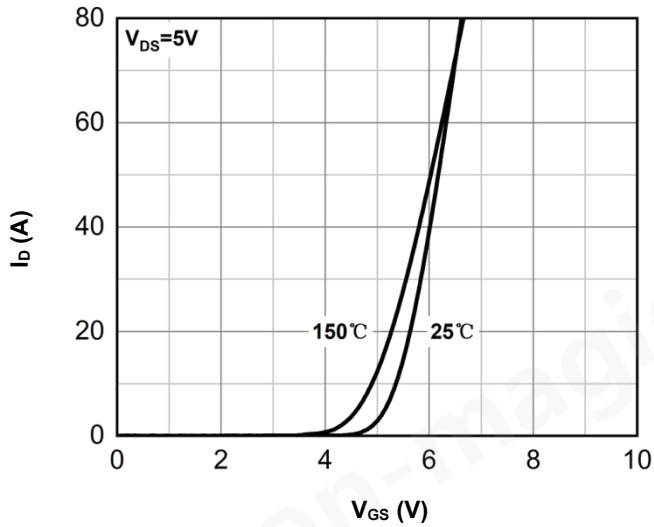


Fig.2 Typ. output characteristics

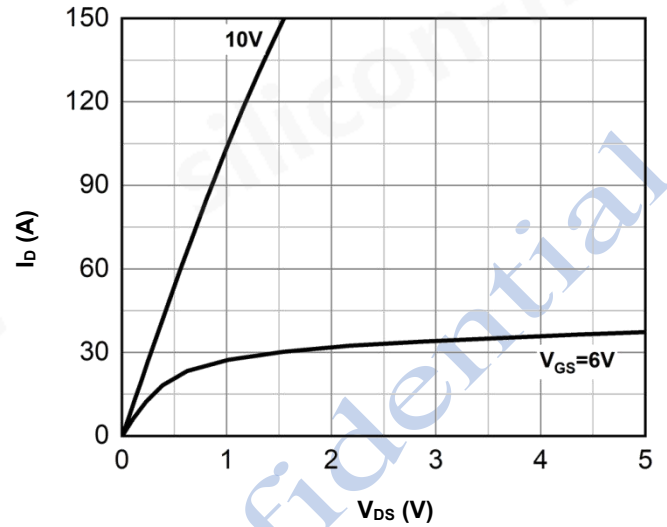


Fig.3 Normalized on-resistance vs drain current

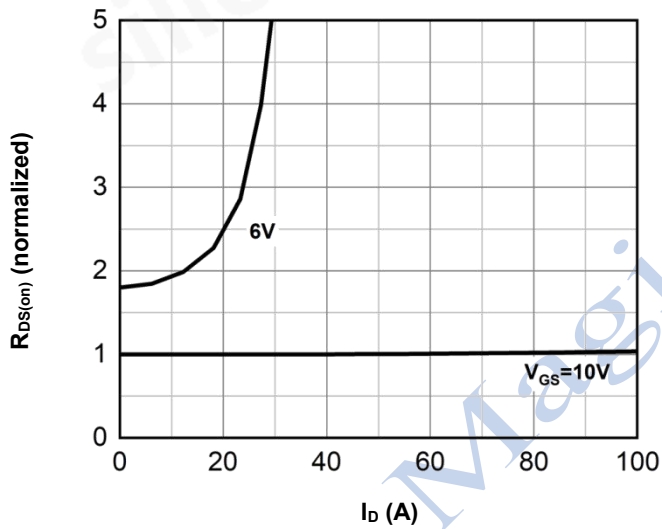


Fig.4 Typ. on-resistance vs gate-source voltage

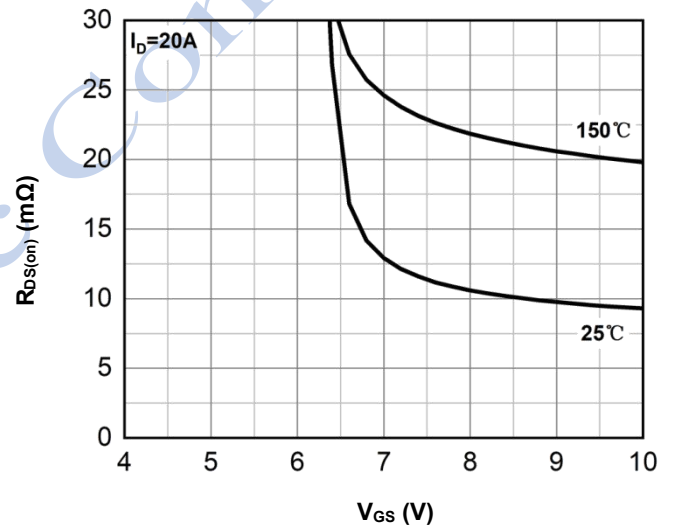


Fig.5 Normalized on-resistance vs junction temperature

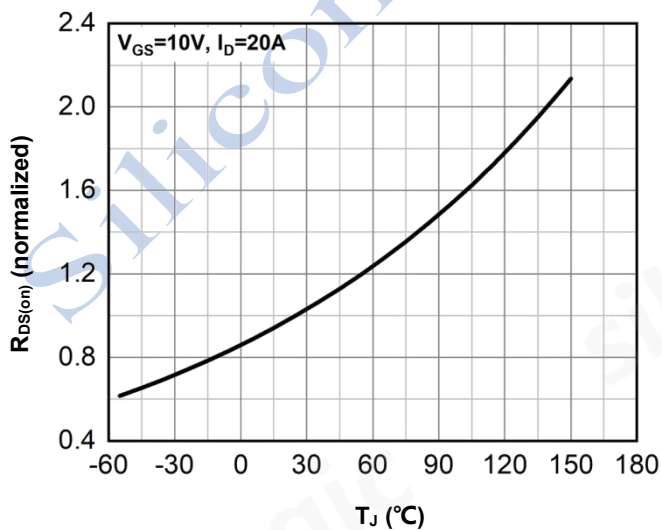


Fig.6 Typ. gate charge

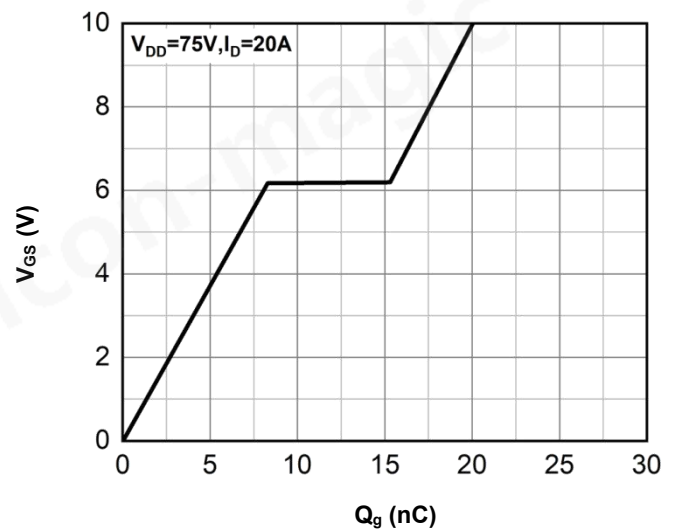


Fig.7 Typ. forward characteristics of body diode

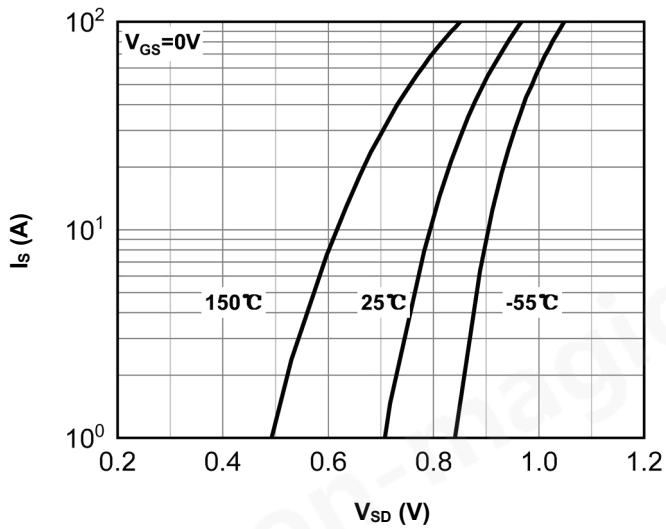


Fig.8 Safe operating area

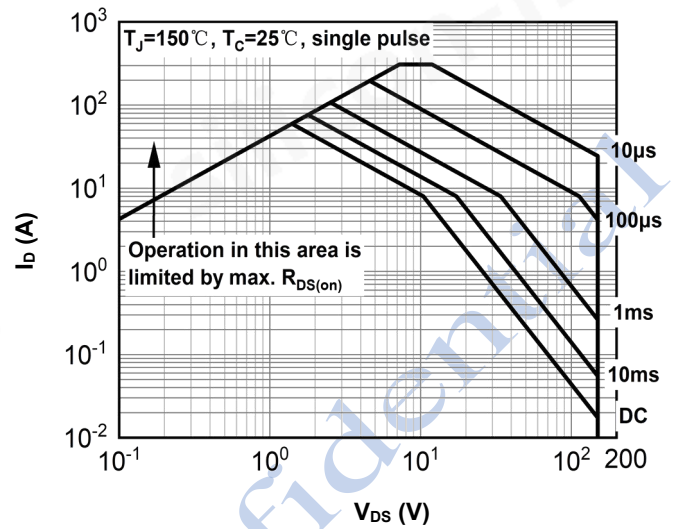


Fig.9 Typ. Capacitance

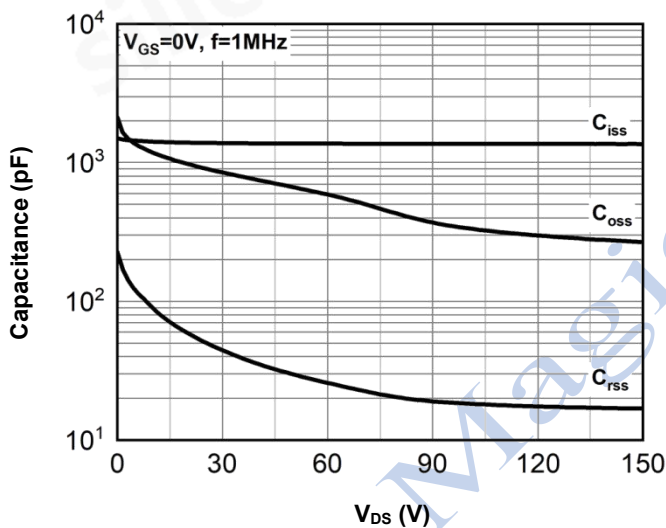


Fig.10 Single pulse maximum power dissipation

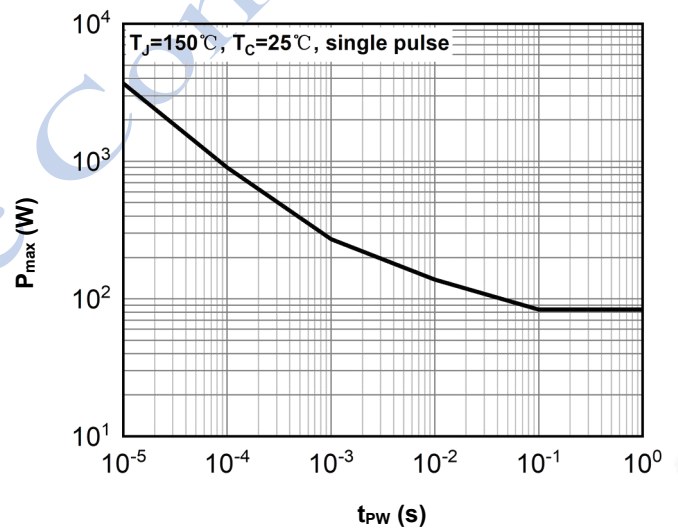


Fig.11 Max. power dissipation vs case temperature

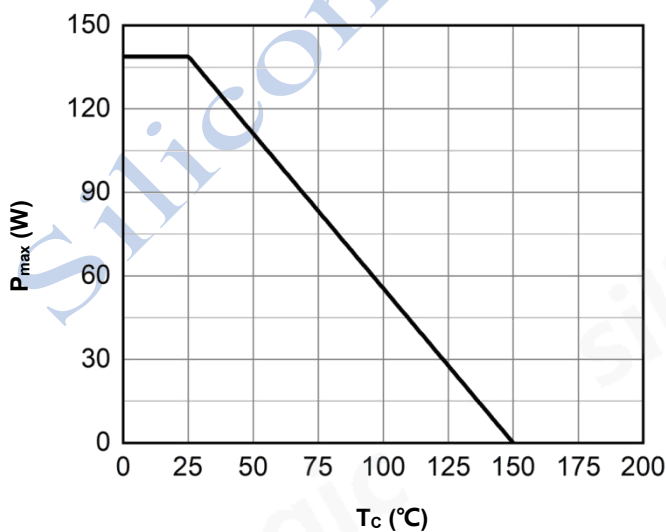


Fig.12 Max. continuous drain current vs case temperature

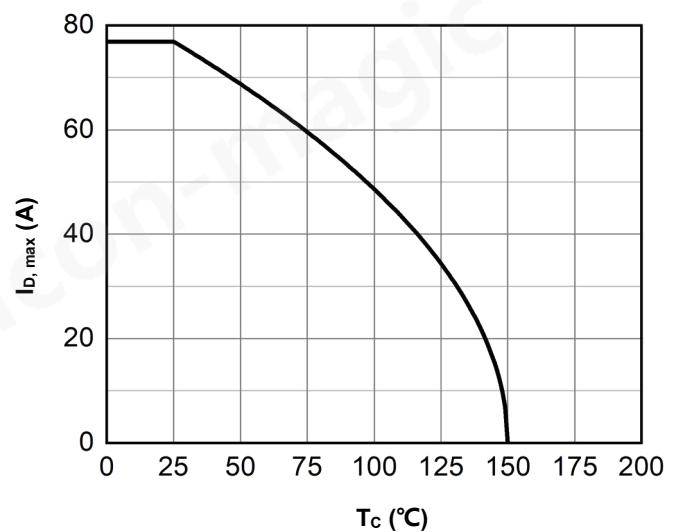


Fig.13 Normalized $V_{(BR)DSS}$ vs junction temperature

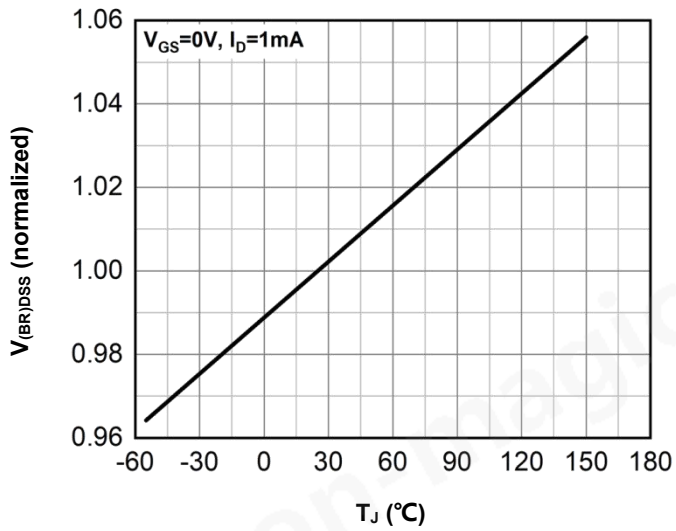


Fig.14 Normalized $V_{GS(th)}$ vs junction temperature

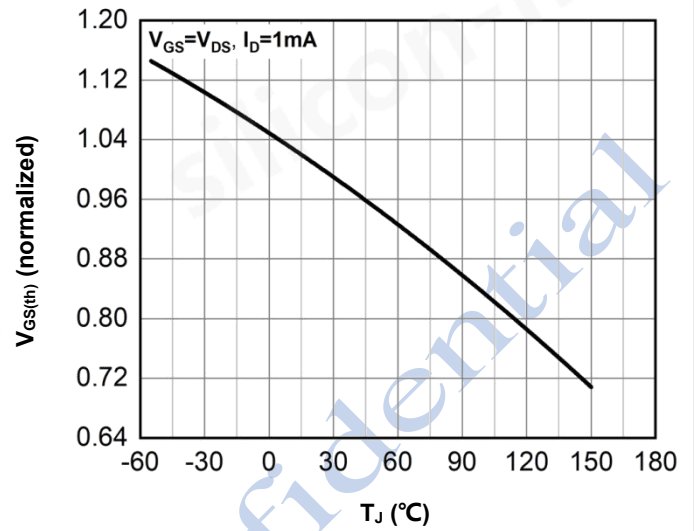
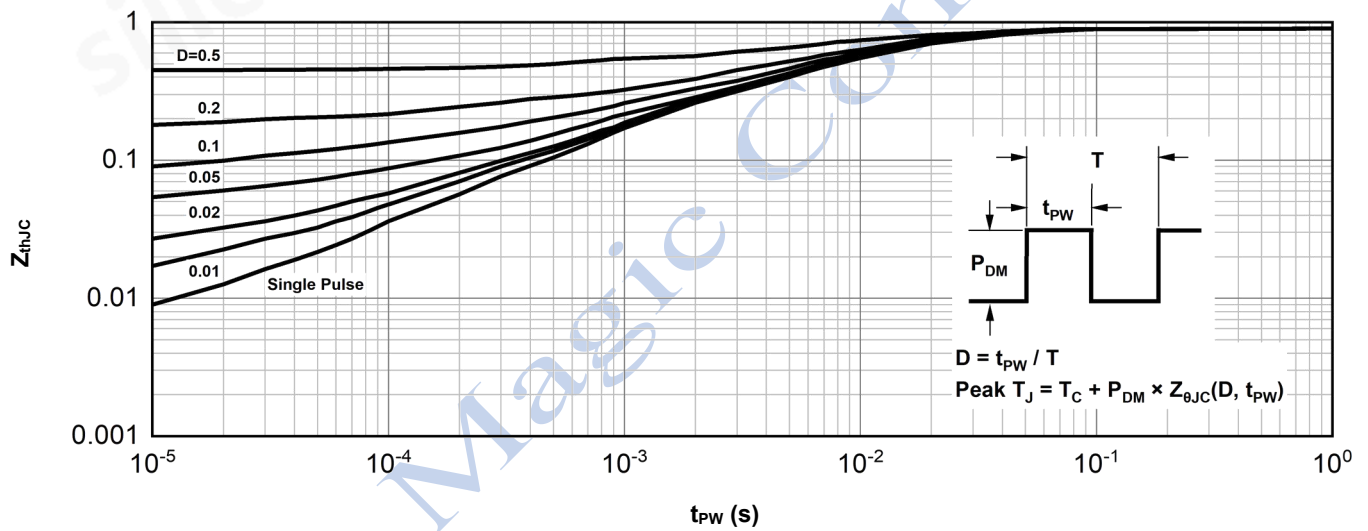
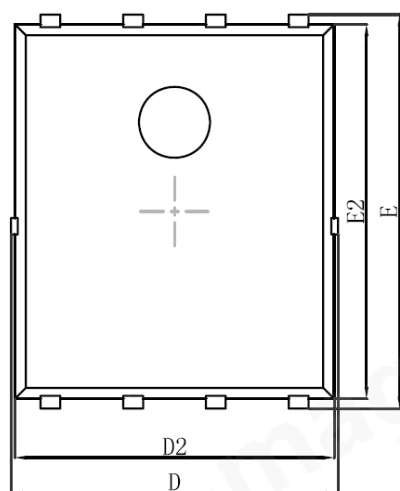


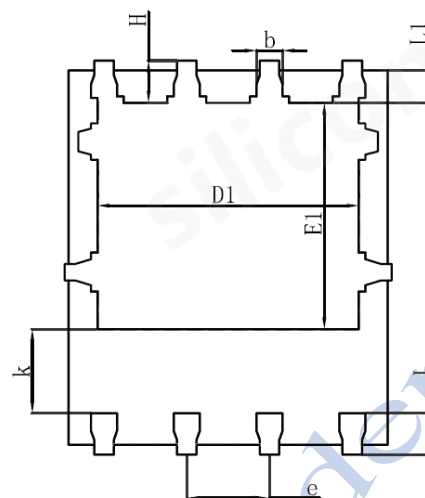
Fig.15 Transient thermal impedance from junction to case



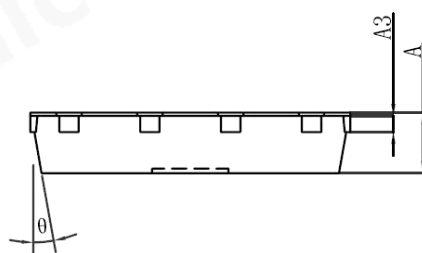
5. Package outline dimensions



Top View



Bottom View



Side View

Dim	Millimeters		
	Min	Nom	Max
A	0.900	—	1.000
A3	0.254 REF		
D	4.944	—	5.096
E	5.974	—	6.126
D1	3.910	—	4.110
E1	3.375	—	3.575
D2	4.824	—	4.976
E2	5.674	—	5.826
k	1.190	—	1.390
b	0.350	—	0.450
e	1.270 TYP		
L	0.559	—	0.711
L1	0.424	—	0.576
H	0.574	—	0.726
θ	10°	—	12°

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